

Receipt date: 07/22/2010

<b>Form 1449 (Modified)</b>  <b>Information Disclosure Statement By Applicant</b>  (Use Several Sheets if Necessary)	<b>Atty Docket No.</b>	GRAMP005
	<b>Application No.:</b>	10/817,564
	<b>Applicant</b>	David Graham
	<b>Filing Date</b>	April 1, 2004
	<b>Group</b>	2629
		Page 1 of 1

**U.S. Patent Documents**

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
	1.						

**Foreign Patent or Published Foreign Patent Application**

Examiner Initial		Document No.	Publication Date	Country or Patent Office	Class	Sub-Class	Translation	
							Yes	No
/J.H.N/	2.	JP 2001-514779A	09/11/01	JP				
↓	3.	JP 61-043326A	03/01/86	JP			Abstract	
	4.	JP 11-119912A	04/30/99	JP			Yes	
	5.	JP 07-253853A	10/03/95	JP			Yes	
	6.	JP 62-128318A	06/10/87	JP			Abstract	

**Other Documents**

Examiner Initial	No.	Author, Title, Place (e.g. Journal) of Publication, Date
/J.H.N/	7.	Office Action in Chinese Patent Application No. 200580026392.8 dated December 12, 2008.
/J.H.N/	8.	Notice of Allowance in 10/862,003, mailed March 9, 2009.
	<del>9.</del>	<del>Allowed Claims from 10/862,003.</del>
/J.H.N/	10.	Office Action in Japanese Patent Application No. 2006-509663 dated October 13, 2009
↓	11.	Notice of Allowance dated January 8, 2009 from U.S. Patent Application No. 11/612,099
	12.	Office Action dated March 18, 2009 from U.S. Patent Application No. 11/498,365
	13.	Paloczi et al. "Free-standing All-polymer Microring Resonator Optical Filter", Electronics Letters, IEE Stevebage, GB, Vol. 39, No. 23, Nov. 13, 2003, 2 pages
	14.	International Search Report dated March 22, 2006 from International Patent Application No. PCT/US2005/019560
↓	15.	Written Opinion dated March 22, 2006 from International Patent Application No. PCT/US2005/019560
/J.H.N/	16.	International Search Report dated November 22, 2005 from International Patent Application No. PCT/US2005/019480

<b>Examiner</b> /Jimmy H. Nguyen/	<b>Date Considered</b> 07/27/2010
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Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

**ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /J.H.N/**